

# IRFP460C

## **500V N-Channel MOSFET**

# **General Description**

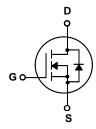
These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supplies and power factor corrections.

### **Features**

- 20A, 500V,  $R_{DS(on)}$  = 0.24 $\Omega$  @V<sub>GS</sub> = 10 V Low gate charge ( typical 130nC)
- Low Crss (typical 60 pF)
- · Fast switching
- 100% avalanche tested
- · Improved dv/dt capability





# Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		IRFP460C	Units
V <sub>DSS</sub>	Drain-Source Voltage		500	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°	C)	20	А
	- Continuous (T <sub>C</sub> = 100	°C)	12.5	А
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	80	А
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	1050	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	20	А
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	23.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
$P_D$	Power Dissipation (T <sub>C</sub> = 25°C)		235	W
	- Derate above 25°C		1.88	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

# **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.53	°C/W
R <sub>θCS</sub> Thermal Resistance, Case-to-Sink		0.24		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		40	°C/W

Symbol	Parameter	Test Conditions	3	Min	Тур	Max	Units
Off Ch	naracteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500			V
ΔBV <sub>DSS</sub>	0	VGS = 0 V, 1D = 230 μΛ		300			V
ΔBV <sub>DSS</sub>	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$ , Referenced to 25°C			0.55		V/°C
I <sub>DSS</sub>	Zoro Goto Voltago Proin Current	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V				10	μΑ
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 400 V, T <sub>C</sub> = 125°C				100	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$				100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$				-100	nA
On Ch	naracteristics						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		2.0		4.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10.0 A			0.2	0.24	Ω
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = 50 \text{ V}, I_{D} = 10.0 \text{ A}$	(Note 4)		18		S
	Output Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0  MHz			4590 380	6000 460	pF pF
	Output Capacitance Reverse Transfer Capacitance						
C <sub>rss</sub>	' '				380	460	pF
C <sub>rss</sub>	Reverse Transfer Capacitance				380	460	pF
Switcl	Reverse Transfer Capacitance				380 60	460 80	pF pF
$C_{rss}$ <b>Switcl</b> $t_{d(on)}$ $t_r$	Reverse Transfer Capacitance  ning Characteristics  Turn-On Delay Time	f = 1.0 MHz			380 60 50	460 80	pF pF
$c_{rss}$ Switcl $t_{d(on)}$ $t_r$ $t_{d(off)}$	Reverse Transfer Capacitance  ning Characteristics  Turn-On Delay Time  Turn-On Rise Time	f = 1.0 MHz V <sub>DD</sub> = 250 V, I <sub>D</sub> = 20 A,	(Note 4, 5)		380 60 50 150	460 80 120 310	pF pF
$\frac{\mathbf{C}_{rss}}{\mathbf{Switcl}}$ $\mathbf{t}_{d(on)}$ $\mathbf{t}_{r}$ $\mathbf{t}_{d(off)}$ $\mathbf{t}_{f}$	Reverse Transfer Capacitance  ning Characteristics  Turn-On Delay Time  Turn-On Rise Time  Turn-Off Delay Time	f = 1.0  MHz $V_{DD} = 250 \text{ V}, I_D = 20 \text{ A},$ $R_G = 25 \Omega$	(Note 4, 5)		380 60 50 150 380	460 80 120 310 770	pF pF
$\frac{\mathbf{C}_{\mathrm{rss}}}{\mathbf{Switcl}}$ $\frac{\mathbf{t}_{\mathrm{d(on)}}}{\mathbf{t}_{\mathrm{r}}}$ $\frac{\mathbf{t}_{\mathrm{d(off)}}}{\mathbf{t}_{\mathrm{f}}}$ $\mathbf{Q}_{\mathrm{g}}$	Reverse Transfer Capacitance  ning Characteristics  Turn-On Delay Time  Turn-On Rise Time  Turn-Off Delay Time  Turn-Off Fall Time	$I_{DD} = 250 \text{ V}, I_{D} = 20 \text{ A},$ $I_{RG} = 25 \Omega$ $I_{DS} = 400 \text{ V}, I_{D} = 20 \text{ A},$	(Note 4, 5)		380 60 50 150 380 180	460 80 120 310 770 370	pF pF ns ns
$C_{rss}$ Switcl $t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$ $Q_g$ $Q_{gs}$	Reverse Transfer Capacitance  ing Characteristics  Turn-On Delay Time  Turn-On Rise Time  Turn-Off Delay Time  Turn-Off Fall Time  Total Gate Charge	f = 1.0  MHz $V_{DD} = 250 \text{ V}, I_D = 20 \text{ A},$ $R_G = 25 \Omega$	(Note 4, 5)	    	380 60 50 150 380 180	120 310 770 370 170	pF pF ns ns ns
Switcl td(on) tr td(off) tf Q Q Q g Q g d	Reverse Transfer Capacitance  Ining Characteristics  Turn-On Delay Time  Turn-On Rise Time  Turn-Off Delay Time  Turn-Off Fall Time  Total Gate Charge  Gate-Source Charge  Gate-Drain Charge	$f = 1.0 \text{ MHz}$ $V_{DD} = 250 \text{ V}, I_{D} = 20 \text{ A},$ $R_{G} = 25 \Omega$ $V_{DS} = 400 \text{ V}, I_{D} = 20 \text{ A},$ $V_{GS} = 10 \text{ V}$	(Note 4, 5)	   	380 60 50 150 380 180 130 20	120 310 770 370 170	pF pF ns ns ns ns
$egin{array}{ll} \mathbf{C}_{rss} & & & \\ \mathbf{Switcl} & & \\ \mathbf{t}_{d(on)} & & \\ \mathbf{t}_{r} & & \\ \mathbf{t}_{d(off)} & & \\ \mathbf{t}_{f} & & \\ \mathbf{Q}_{g} & & \\ \mathbf{Q}_{gs} & & \\ \mathbf{Q}_{gd} & & \\ \mathbf{Drain-S} & & \\ \end{array}$	Reverse Transfer Capacitance  ning Characteristics  Turn-On Delay Time  Turn-On Rise Time  Turn-Off Delay Time  Turn-Off Fall Time  Total Gate Charge  Gate-Source Charge	$f = 1.0 \text{ MHz}$ $V_{DD} = 250 \text{ V}, I_{D} = 20 \text{ A},$ $R_{G} = 25 \Omega$ $V_{DS} = 400 \text{ V}, I_{D} = 20 \text{ A},$ $V_{GS} = 10 \text{ V}$ and Maximum Ratings	(Note 4, 5)	   	380 60 50 150 380 180 130 20	120 310 770 370 170	pF pF ns ns ns ns
Switcl  td(on)  tr  td(off)  tf  Qg  Qgs  Qgd  Drain-S	Reverse Transfer Capacitance  ning Characteristics  Turn-On Delay Time  Turn-On Rise Time  Turn-Off Delay Time  Turn-Off Fall Time  Total Gate Charge  Gate-Source Charge  Gate-Drain Charge	$f = 1.0 \text{ MHz}$ $V_{DD} = 250 \text{ V}, I_D = 20 \text{ A},$ $R_G = 25 \Omega$ $V_{DS} = 400 \text{ V}, I_D = 20 \text{ A},$ $V_{GS} = 10 \text{ V}$ and Maximum Rating: $V_{DS} = 400 \text{ V}$ $V_{DS} = 400 \text{ V}$	(Note 4, 5)	   	380 60 50 150 380 180 130 20 45	460 80 120 310 770 370 170 	pF pF ns ns ns nc nC
$C_{rss}$ Switcl $t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$ $Q_g$ $Q_{gs}$ $Q_{gd}$ Drain-Substitute $S_{gs}$	Reverse Transfer Capacitance  hing Characteristics  Turn-On Delay Time  Turn-On Rise Time  Turn-Off Delay Time  Turn-Off Fall Time  Total Gate Charge  Gate-Source Charge  Gate-Drain Charge  Source Diode Characteristics and Maximum Continuous Drain-Source Diode	$f = 1.0 \text{ MHz}$ $V_{DD} = 250 \text{ V}, I_D = 20 \text{ A},$ $R_G = 25 \Omega$ $V_{DS} = 400 \text{ V}, I_D = 20 \text{ A},$ $V_{GS} = 10 \text{ V}$ and Maximum Rating: $V_{DS} = 400 \text{ V}$ $V_{DS} = 400 \text{ V}$	(Note 4, 5)	    	380 60 50 150 380 180 130 20 45	460 80 120 310 770 370 170 	pF pF ns ns ns nc nC
t <sub>d(on)</sub> t <sub>r</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Reverse Transfer Capacitance  hing Characteristics  Turn-On Delay Time  Turn-Off Delay Time  Turn-Off Delay Time  Turn-Off Fall Time  Total Gate Charge  Gate-Source Charge  Gate-Drain Charge  Source Diode Characteristics as Maximum Continuous Drain-Source Diode Fall Maximum Pulsed Drain-Source Diode Fall Time	$f = 1.0 \text{ MHz}$ $V_{DD} = 250 \text{ V}, I_D = 20 \text{ A},$ $R_G = 25 \Omega$ $V_{DS} = 400 \text{ V}, I_D = 20 \text{ A},$ $V_{GS} = 10 \text{ V}$ And Maximum Ratings of the Forward Current Forward Curren	(Note 4, 5)		380 60 50 150 380 180 130 20 45	120 310 770 370 170 	ns ns ns nC nC nC

- $\label{eq:Notes:1} \begin{tabular}{ll} \textbf{Notes:} \\ 1. & \textbf{Repetitive Rating: Pulse width limited by maximum junction temperature} \\ 2. & \textbf{L} = 5.1 \text{mH, } |_{AS} = 20 \text{A, } |_{DD} = 50 \text{V, } |_{RG} = 25 \ \Omega, \text{ Starting } |_{J} = 25 \ \text{°C} \\ 3. & \textbf{l}_{SD} \leq 20 \text{A, } \text{didd} \leq 200 \text{A/µs, } |_{DD} \leq \text{BV}_{DSS}, \text{ Starting } |_{J} = 25 \ \text{°C} \\ 4. & \textbf{Pulse Test: Pulse width} \leq 300 \ \mu\text{s, Duty cycle} \leq 2 \ \text{\%} \\ 5. & \textbf{Essentially independent of operating temperature} \\ \end{tabular}$

# **Typical Characteristics**

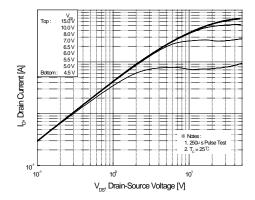


Figure 1. On-Region Characteristics

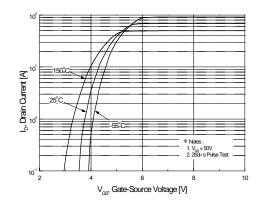


Figure 2. Transfer Characteristics

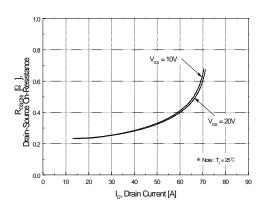


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

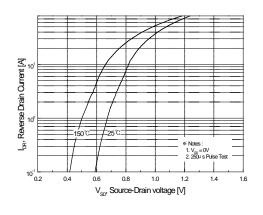


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

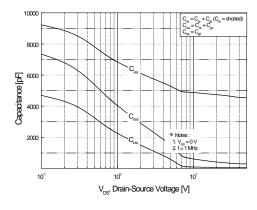


Figure 5. Capacitance Characteristics

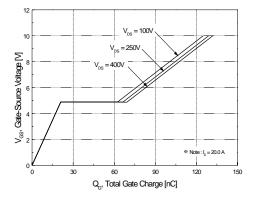


Figure 6. Gate Charge Characteristics

Dimensions in Millimeters

# Typical Characteristics (Continued)

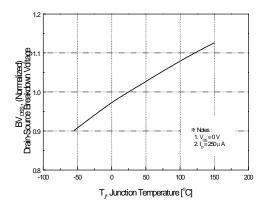
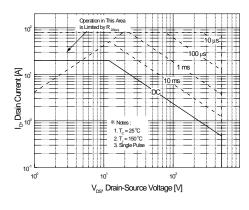


Figure 7. Breakdown Voltage Variation vs Temperature

Figure 8. On-Resistance Variation vs Temperature



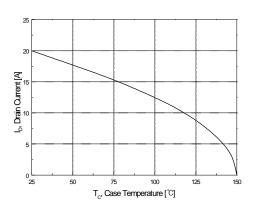


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs Case Temperature

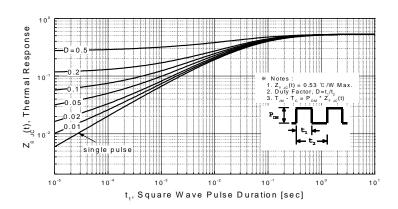
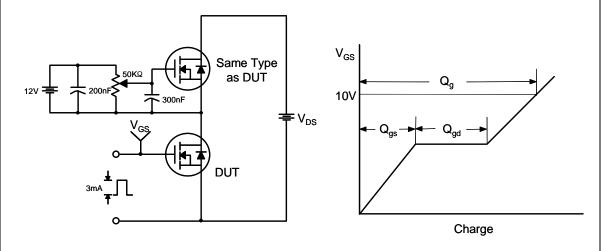


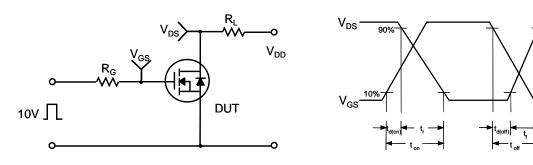
Figure 11. Transient Thermal Response Curve

Dimensions in Millimeters

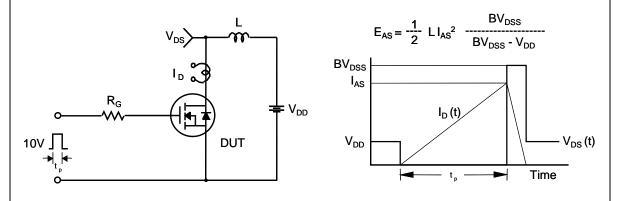
# **Gate Charge Test Circuit & Waveform**



## **Resistive Switching Test Circuit & Waveforms**

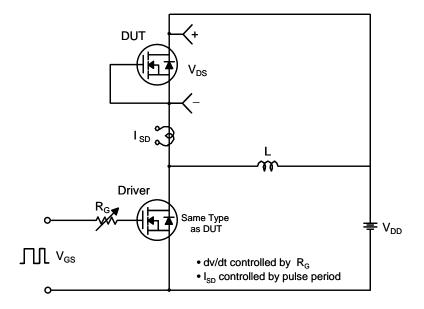


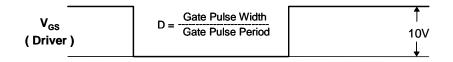
# **Unclamped Inductive Switching Test Circuit & Waveforms**

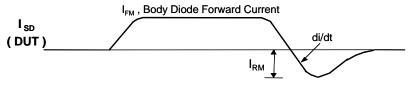


Dimensions in Millimeters

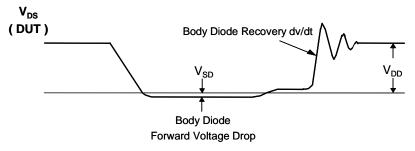
#### Peak Diode Recovery dv/dt Test Circuit & Waveforms

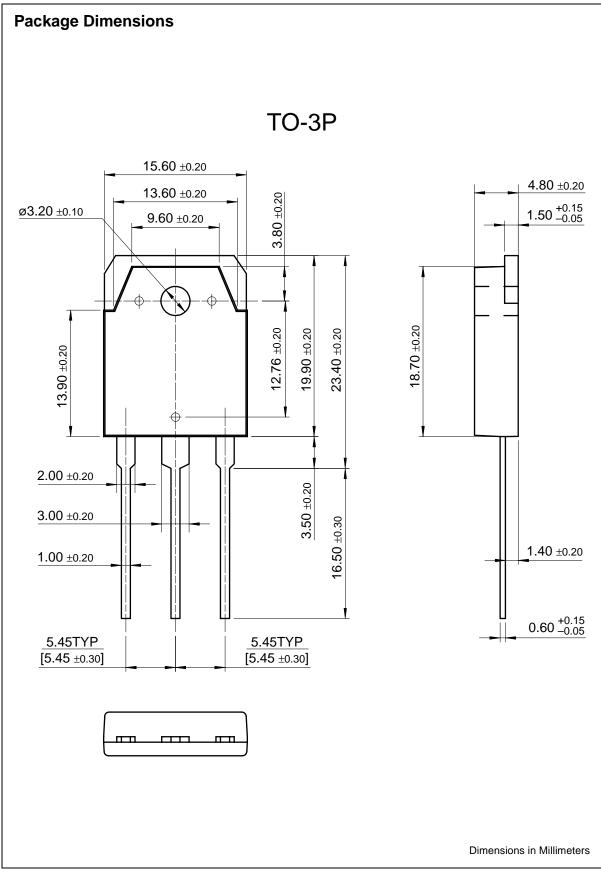






Body Diode Reverse Current





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DOME™	HiSeC™	PowerTrench <sup>®</sup>	SuperSOT™-8	
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